

The Wideband IC Line

RF LDMOS Wideband Integrated Power Amplifiers

The MW4IC2230 wideband integrated circuit is designed for W-CDMA base station applications. It uses Motorola's newest High Voltage (26 to 28 Volts) LDMOS IC technology and integrates a multi-stage structure. Its wideband On-Chip design makes it usable from 1600 to 2400 MHz. The linearity performances cover all modulations for cellular applications: GSM, GSM EDGE, TDMA, CDMA and W-CDMA.

Final Application

Typical Single-carrier W-CDMA Performance: $V_{DD} = 28$ Volts, $I_{DQ1} = 60$ mA, $I_{DQ2} = 350$ mA, $P_{out} = 5$ Watts Avg., $f = 2140$ MHz, Channel Bandwidth = 3.84 MHz, Peak/Avg. = 8.5 dB @ 0.01% Probability on CCDF.

Power Gain — 31 dB

Drain Efficiency — 15%

ACPR @ 5 MHz = -45 dBc @ 3.84 MHz Bandwidth

Driver Application

Typical Single-carrier W-CDMA Performance: $V_{DD} = 28$ Volts, $I_{DQ1} = 60$ mA, $I_{DQ2} = 350$ mA, $P_{out} = 0.4$ Watts Avg., $f = 2140$ MHz, Channel Bandwidth = 3.84 MHz, Peak/Avg. = 8.5 dB @ 0.01% Probability on CCDF.

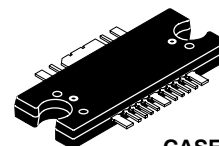
Power Gain — 31.5 dB

ACPR @ 5 MHz = -53.5 dBc @ 3.84 MHz Bandwidth

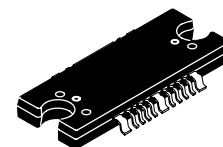
- Capable of Handling 3:1 VSWR, @ 28 Vdc, 2170 MHz, 5 Watts CW Output Power
- Characterized with Series Equivalent Large-Signal Impedance Parameters
- On-Chip Matching (50 Ohm Input, DC Blocked, >5 Ohm Output)
- Integrated Temperature Compensation with Enable/Disable Function
- On-Chip Current Mirror g_m Reference FET for Self Biasing Application (1)
- Integrated ESD Protection
- Also Available in Gull Wing for Surface Mount
- In Tape and Reel. R1 Suffix = 500 Units per 44 mm, 13 inch Reel

MW4IC2230MBR1
MW4IC2230GMBR1

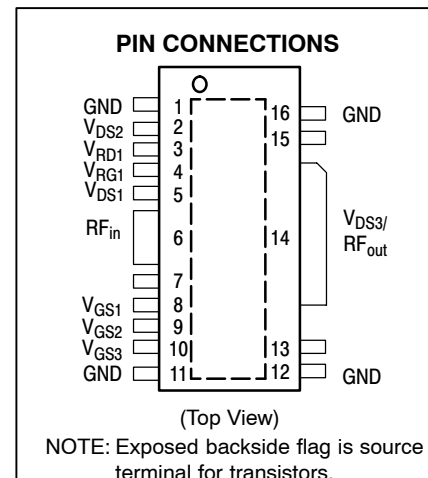
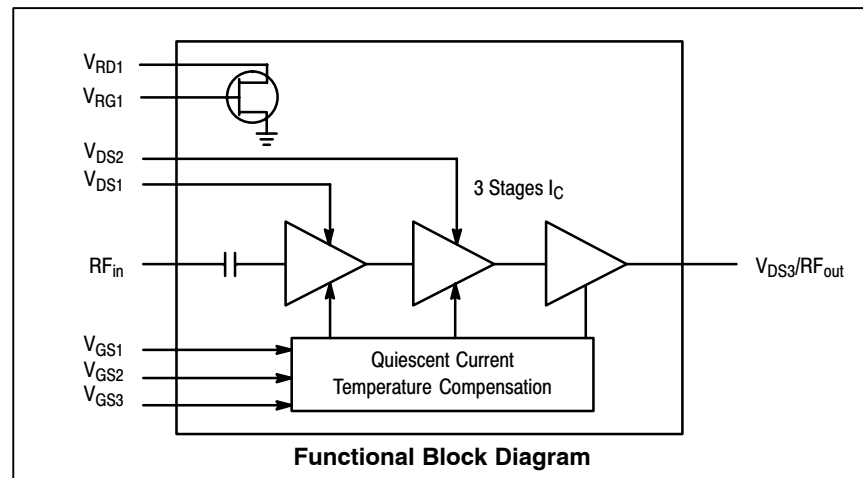
2110-2170 MHz, 30 W, 28 V
SINGLE W-CDMA
RF LDMOS WIDEBAND
INTEGRATED POWER AMPLIFIERS



CASE 1329-09
TO-272 WB-16
PLASTIC
MW4IC2230MBR1



CASE 1329A-03
TO-272 WB-16 GULL
PLASTIC
MW4IC2230GMBR1



(1) Refer to AN1987/D, *Quiescent Current Control for the RF Integrated Circuit Device Family*. Go to <http://www.motorola.com/semiconductors/rf>. Select Documentation/Application Notes - AN1987.

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MAXIMUM RATINGS

Rating	Symbol	Value	Unit
Drain-Source Voltage	V_{DS}	65	Vdc
Gate-Source Voltage	V_{GS}	-0.5, +8	Vdc
Storage Temperature Range	T_{stg}	-65 to +175	°C
Operating Channel Temperature	T_J	175	°C
Input Power	P_{in}	20	dBm

THERMAL CHARACTERISTICS

Characteristic	Symbol	Value (1)	Unit
Thermal Resistance, Junction to Case	$R_{\theta JC}$	10.5 5.1 2.3	°C/W
Stage 1			
Stage 2			
Stage 3			

ESD PROTECTION CHARACTERISTICS

Test Conditions	Class
Human Body Model	2 (Minimum)
Machine Model	M3 (Minimum)
Charge Device Model	C5 (Minimum)

MOISTURE SENSITIVITY LEVEL

Test Methodology	Rating
Per JESD 22-A113	3

ELECTRICAL CHARACTERISTICS ($T_C = 25^\circ\text{C}$ unless otherwise noted)

Characteristic	Symbol	Min	Typ	Max	Unit
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FUNCTIONAL TESTS (In Motorola Test Fixture, 50 ohm system) $V_{DD} = 28$ Vdc, $I_{DQ1} = 60$ mA, $I_{DQ2} = 350$ mA, $I_{DQ3} = 265$ mA, $P_{out} = 0.4$ W Avg., $f = 2110$ MHz, $f = 2170$ MHz, Single-carrier W-CDMA. ACPR measured in 3.84 MHz Channel Bandwidth @ ± 5 MHz Offset. Peak/Avg. Ratio = 8.5 dB @ 0.01% Probability on CCDF.

Power Gain	G_{ps}	29	31.5	—	dB
Input Return Loss	IRL	—	-25	-10	dB
Adjacent Channel Power Ratio	ACPR	—	-53.5	-50	dBc
		$P_{out} = 0.4$ W Avg.	—	—	
		$P_{out} = 1.26$ W Avg.	-52	—	
Stability (10 mW < P_{out} < 5 W CW, Load VSWR = 3:1, All Phase Angles, 24 V < V_{ds} < 28 V)		No Spurious > -60 dBc			

TYPICAL PERFORMANCES (In Motorola Test Fixture tuned for 0.4 W Avg. W-CDMA driver) $V_{DD} = 28$ Vdc, $I_{DQ1} = 60$ mA, $I_{DQ2} = 350$ mA, $I_{DQ3} = 265$ mA, 2110 MHz < Frequency < 2170 MHz

Saturated Pulsed Output Power ($f = 1$ kHz, Duty Cycle 10%)	P_{sat}	—	43	—	Watts
Quiescent Current Accuracy over Temperature (-10 to 85°C)	ΔI_{QT}	—	± 5	—	%
Gain Flatness in 30 MHz Bandwidth	G_F	—	0.13	—	dB
Deviation from Linear Phase in 30 MHz Bandwidth	Φ	—	± 1	—	°
Delay @ $P_{out} = 0.4$ W CW Including Output Matching	Delay	—	1.6	—	ns
Part to Part Phase Variation	$\Phi\Delta$	—	± 15	—	°

(1) MTTF calculator available at <http://www.motorola.com/semiconductors/rf>. Select Tools/Software/Application Software/Calculators to access the MTTF calculators by product.

(continued)

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ELECTRICAL CHARACTERISTICS — continued ($T_C = 25^\circ\text{C}$ unless otherwise noted)

Characteristic	Symbol	Min	Typ	Max	Unit
TYPICAL PERFORMANCES (In Motorola Reference Application Circuit tuned for 2-carrier W-CDMA signal) $V_{DD} = 28\text{ Vdc}$, $P_{out} = 0.4\text{ W Avg.}$, $I_{DQ1} = 60\text{ mA}$, $I_{DQ2} = 400\text{ mA}$, $I_{DQ3} = 245\text{ mA}$, $f_1 = 2112.5\text{ MHz}$, $f_2 = 2122.5\text{ MHz}$ and $f_1 = 2157.5\text{ MHz}$, $f_2 = 2167.5\text{ MHz}$, 2-carrier W-CDMA, 3.84 MHz Channel Bandwidth Carriers. ACPR measured in 3.84 MHz Channel Bandwidth @ $\pm 5\text{ MHz}$ Offset. IM3 measured in 3.84 MHz Channel Bandwidth @ $\pm 10\text{ MHz}$ Offset. Peak/Avg. = 8.5 dB @ 0.01% Probability on CCDF.					
Power Gain	G_{ps}	—	31.5	—	dB
Intermodulation Distortion	IM3	—	-52	—	dBc
Adjacent Channel Power Ratio	ACPR	—	-55	—	dBc
Input Return Loss	IRL	—	-26	—	dB

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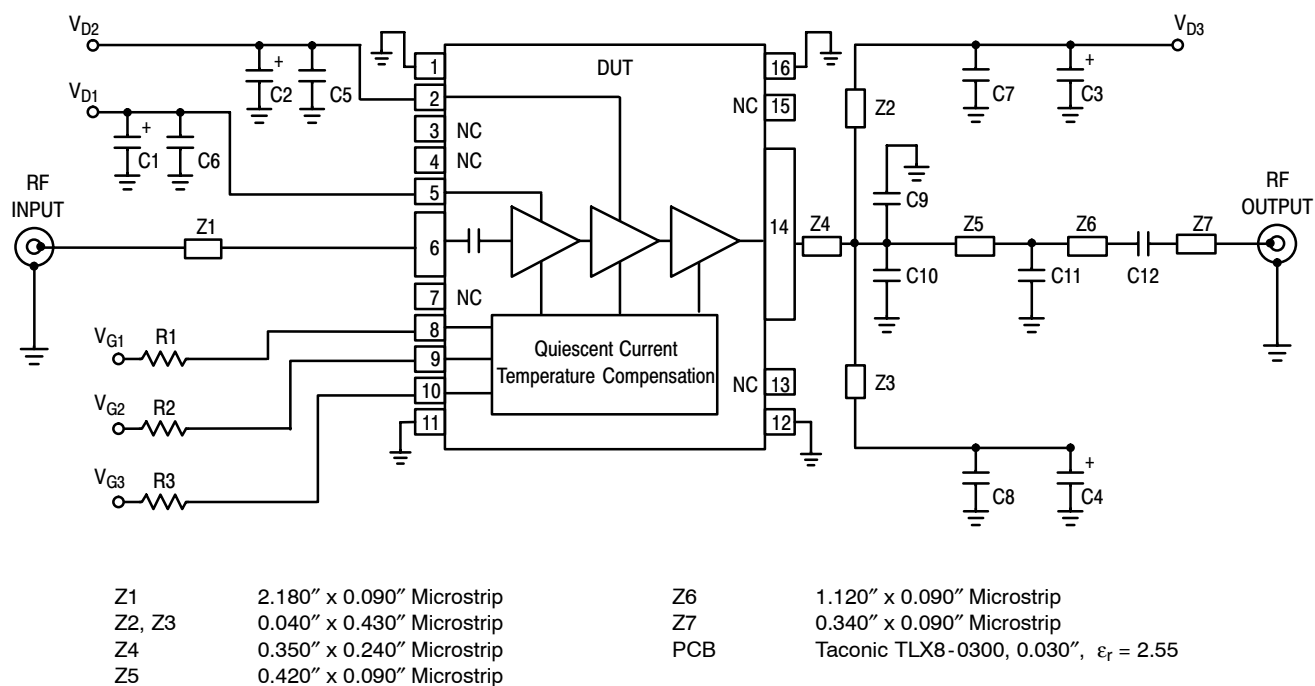


Figure 1. MW4IC2230MBR1(GMBR1) Test Circuit Schematic

Table 1. MW4IC2230MBR1(GMBR1) Test Circuit Component Designations and Values

Part	Description	Part Number	Manufacturer
C1, C2, C3, C4	10 μ F, 35 V Tantalum Capacitors	TAJD106K035	AVX
C5, C6, C7, C8, C12	8.2 pF 100B Chip Capacitors	100B8R2CW	ATC
C9, C10	1.8 pF 100B Chip Capacitors	100B1R8BW	ATC
C11	0.3 pF 100B Chip Capacitor	100B0R3BW	ATC
R1, R2, R3	1.8 k Ω Chip Resistors (1206)		

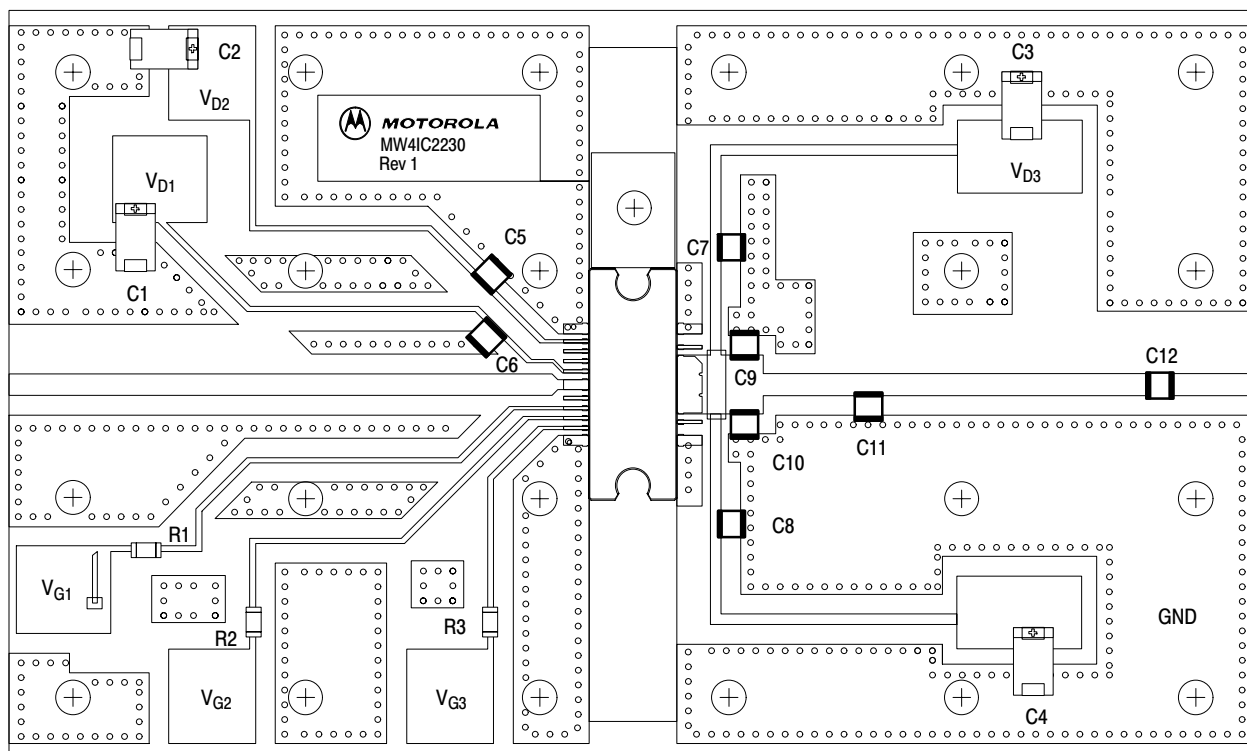


Figure 2. MW4IC2230MBR1(GMBR1) Test Circuit Component Layout

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TYPICAL CHARACTERISTICS

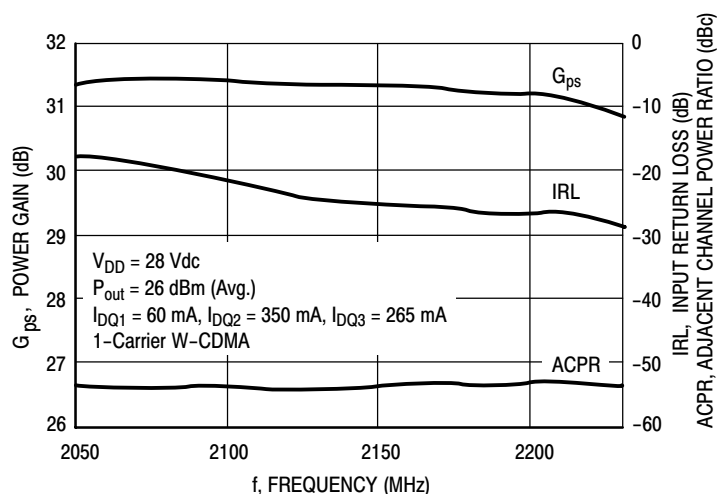


Figure 3. Single-Carrier W-CDMA Wideband Performance

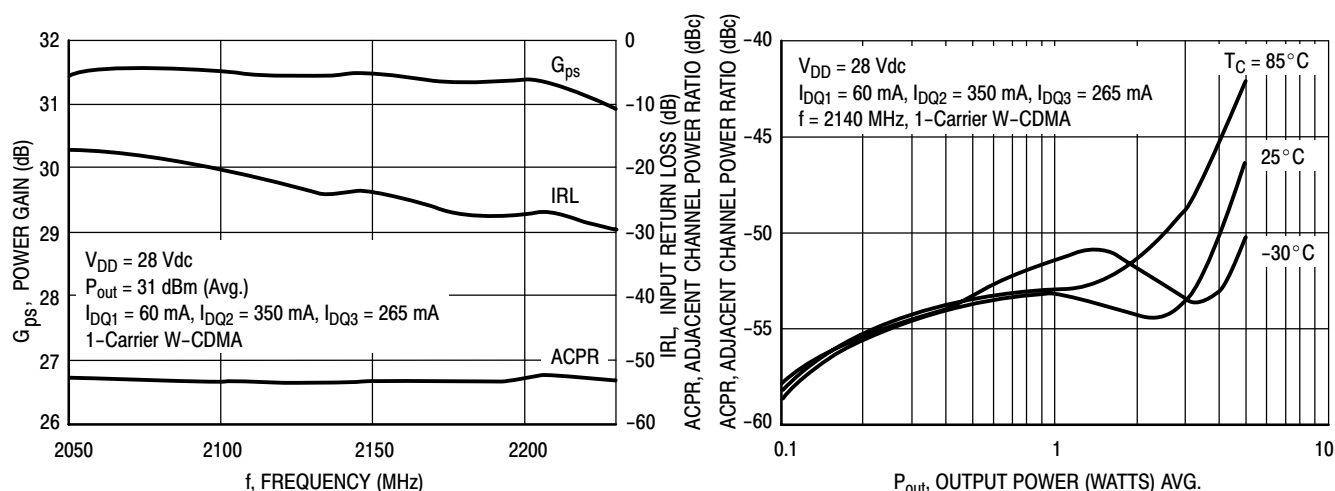


Figure 4. Single-Carrier W-CDMA Wideband Performance

Figure 5. Adjacent Channel Power Ratio versus Output Power

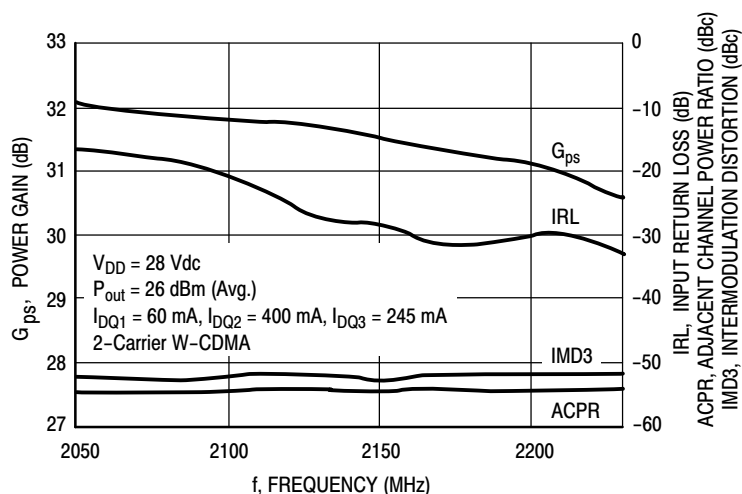


Figure 6. 2-Carrier W-CDMA Wideband Performance

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TYPICAL CHARACTERISTICS

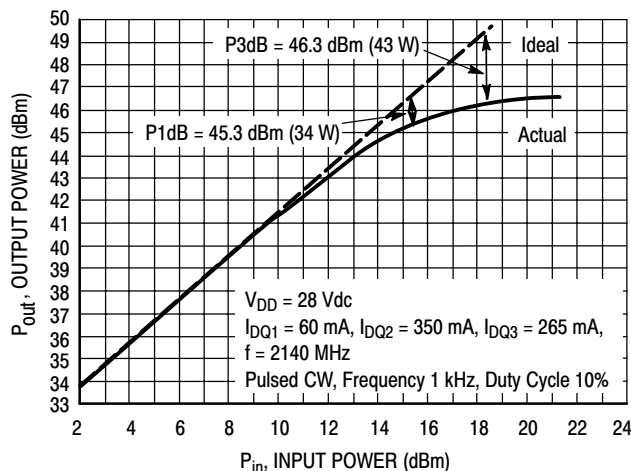


Figure 7. Output Power versus Input Power

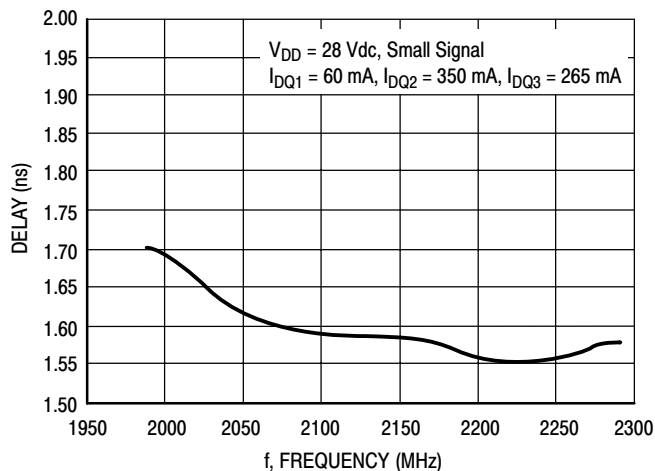
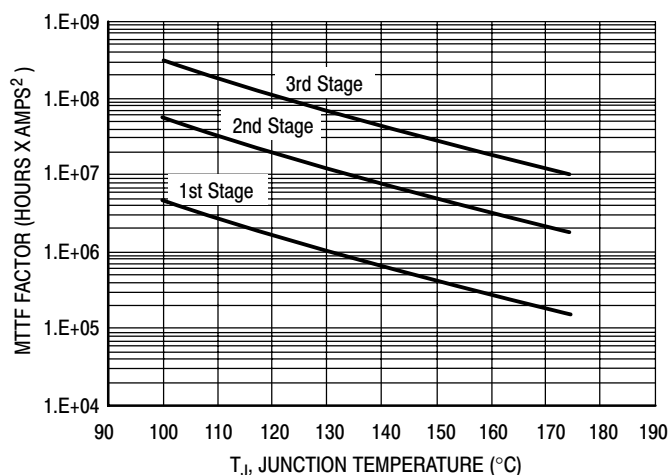
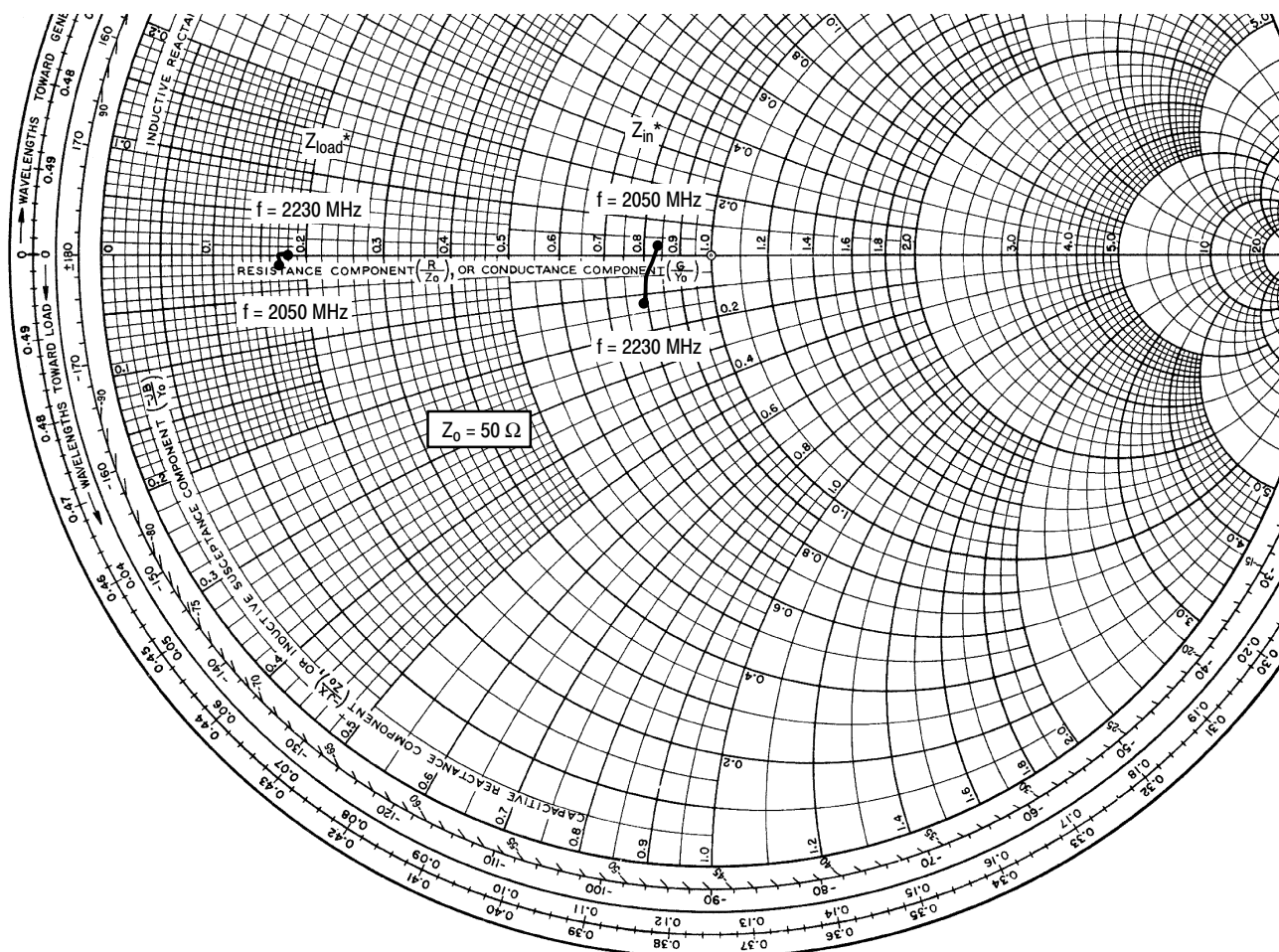


Figure 8. Delay versus Frequency



This above graph displays calculated MTTF in hours x ampere² drain current. Life tests at elevated temperatures have correlated to better than $\pm 10\%$ of the theoretical prediction for metal failure. Divide MTTF factor by I_D^2 for MTTF in a particular application.

Figure 9. MTTF Factor versus Temperature Junction



$V_{DD} = 28\text{ V}$, $I_{DQ1} = 60\text{ mA}$, $I_{DQ2} = 350\text{ mA}$, $I_{DQ3} = 265\text{ mA}$, $P_{out} = 26\text{ dBm}$

f MHz	Z_{in} Ω	Z_{load} Ω
2050	$42.18 + j1.49$	$8.52 - j0.46$
2110	$41.06 - j1.30$	$8.58 - j0.20$
2140	$40.49 - j2.42$	$8.63 - j0.09$
2170	$40.05 - j3.45$	$8.69 - j0.01$
2230	$39.29 - j6.31$	$8.81 + j0.04$

Z_{in} = Device input impedance as measured from gate to ground.

Z_{load} = Test circuit impedance as measured from drain to ground.

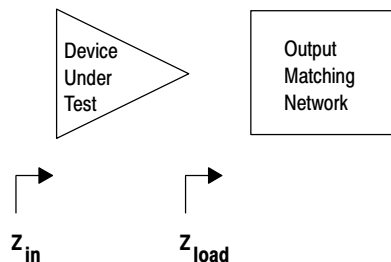
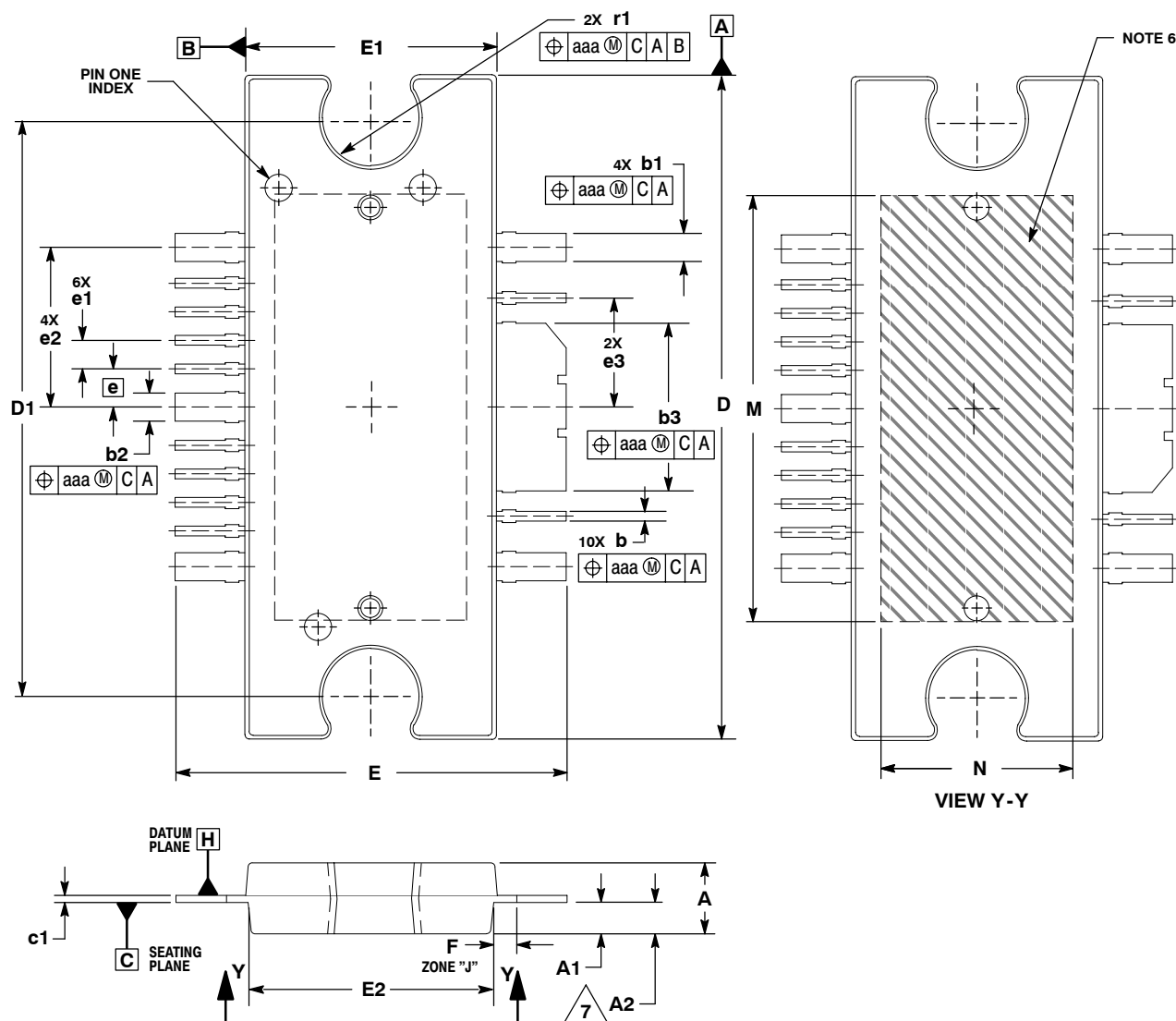


Figure 10. Series Equivalent Input and Load Impedance

NOTES

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PACKAGE DIMENSIONS

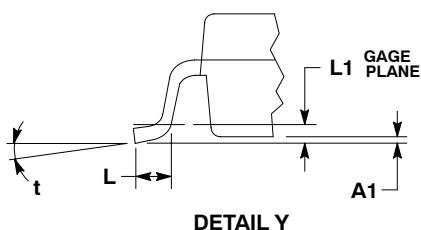
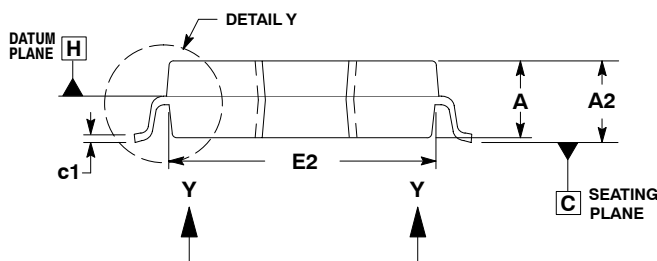
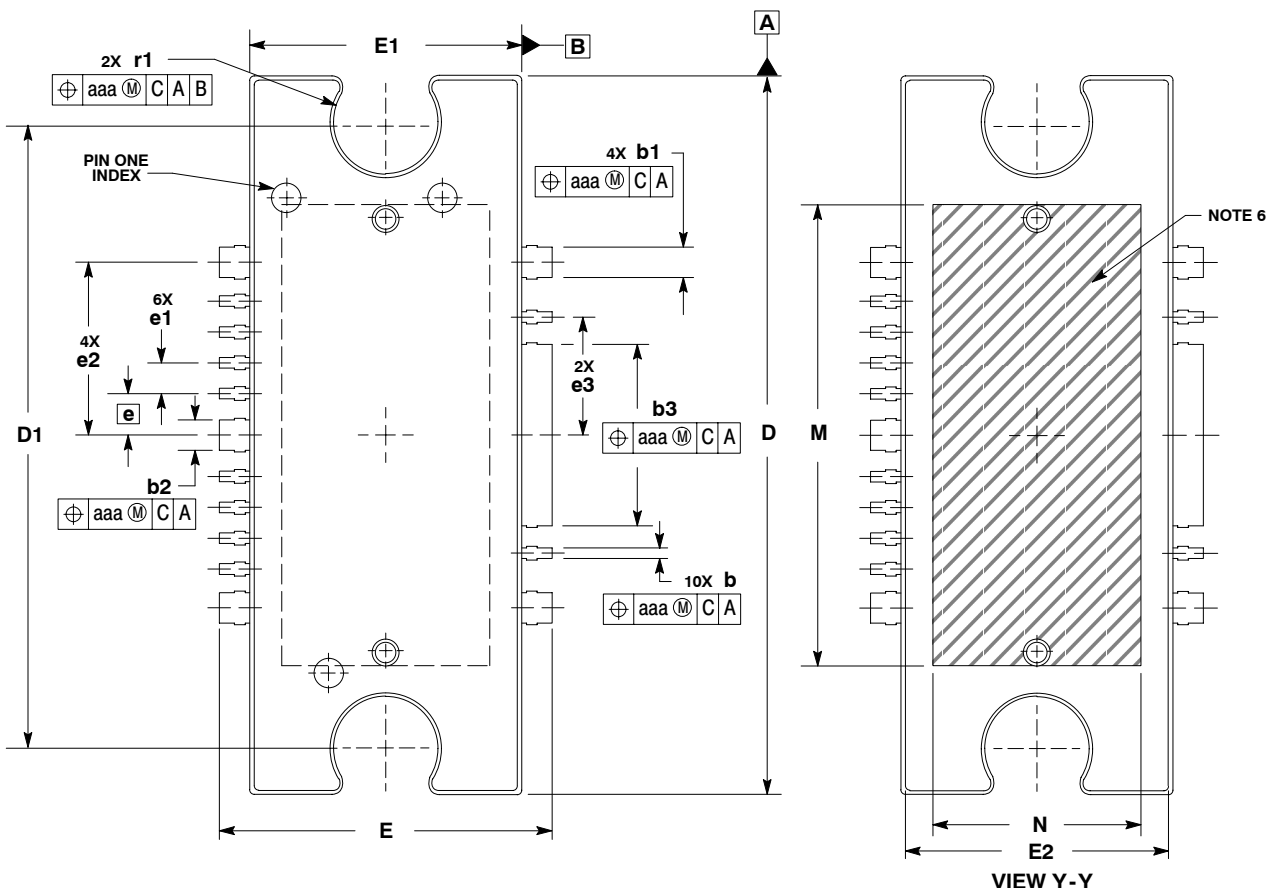


NOTES:

1. CONTROLLING DIMENSION: INCH.
2. INTERPRET DIMENSIONS AND TOLERANCES PER ASME Y14.5M-1994.
3. DATUM PLANE -H- IS LOCATED AT TOP OF LEAD AND IS COINCIDENT WITH THE LEAD WHERE THE LEAD EXITS THE PLASTIC BODY AT THE TOP OF THE PARTING LINE.
4. DIMENSIONS "D" AND "E1" DO NOT INCLUDE MOLD PROTRUSION. ALLOWABLE PROTRUSION IS .006 (0.15) PER SIDE. DIMENSIONS "D" AND "E1" DO INCLUDE MOLD MISMATCH AND ARE DETERMINED AT DATUM PLANE -H-.
5. DIMENSIONS "b", "b1", "b2" AND "b3" DO NOT INCLUDE DAMBAR PROTRUSION. ALLOWABLE DAMBAR PROTRUSION SHALL BE .005 (0.13) TOTAL IN EXCESS OF THE "b", "b1", "b2" AND "b3" DIMENSIONS AT MAXIMUM MATERIAL CONDITION.
6. HATCHING REPRESENTS THE EXPOSED AREA OF THE HEAT SLUG.
7. DIM A2 APPLIES WITHIN ZONE "J" ONLY.

DIM	INCHES		MILLIMETERS	
	MIN	MAX	MIN	MAX
A	.100	.104	2.54	2.64
A1	.038	.044	0.96	1.12
A2	.040	.042	1.02	1.07
D	.928	.932	23.57	23.67
D1	.810 BSC		20.57 BSC	
E	.551	.559	14.00	14.20
E1	.353	.357	8.97	9.07
E2	.346	.350	8.79	8.89
F	.025 BSC		0.64 BSC	
M	.600	---	15.24	---
N	.270	---	6.86	---
b	.011	.017	0.28	0.43
b1	.037	.043	0.94	1.09
b2	.037	.043	0.94	1.09
b3	.225	.231	5.72	5.87
c1	.007	.011	.18	.28
e	.054 BSC		1.37 BSC	
e1	.040 BSC		1.02 BSC	
e2	.224 BSC		5.69 BSC	
e3	.150 BSC		3.81 BSC	
r1	.063	.068	1.6	1.73
aaa	.004		.10	

CASE 1329-09
ISSUE J
TO-272 WB-16
PLASTIC
MW4IC2230MBR1



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5. DIMENSIONS "b", "b1", "b2" AND "b3" DO NOT INCLUDE DAMBAR PROTRUSION. ALLOWABLE DAMBAR PROTRUSION SHALL BE .005 (0.13) TOTAL IN EXCESS OF THE "b", "b1", "b2" AND "b3" DIMENSIONS AT MAXIMUM MATERIAL CONDITION.
6. HATCHING REPRESENTS THE EXPOSED AREA OF THE HEAT SINK.

DIM	INCHES		MILLIMETERS	
	MIN	MAX	MIN	MAX
A	.100	.104	2.54	2.64
A1	.001	.004	0.02	0.10
A2	.099	.110	2.51	2.79
D	.928	.932	23.57	23.67
D1	.810 BSC		20.57 BSC	
E	.429	.437	10.90	11.10
E1	.353	.357	8.97	9.07
E2	.346	.350	8.79	8.89
L	.018	.024	4.90	5.06
L1	.01 BSC		0.25 BSC	
M	.600	---	15.24	---
N	.270	---	6.86	---
b	.011	.017	0.28	0.43
b1	.037	.043	0.94	1.09
b2	.037	.043	0.94	1.09
b3	.225	.231	5.72	5.87
c1	.007	.011	.18	.28
e	.054 BSC		1.37 BSC	
e1	.040 BSC		1.02 BSC	
e2	.224 BSC		5.69 BSC	
e3	.150 BSC		3.81 BSC	
r1	.063	.068	1.6	1.73
t	2°	8°	2°	8°
aaa	.004		.10	

**CASE 1329A-03
ISSUE B
TO-272 WB-16 GULL
PLASTIC
MW4IC2230GMBR1**

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